In place of PTO-1449 Form	U. S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	Complete if Known	
		Application Number	10/685,824
		Filing Date	October 13, 2003
		Applicant(s)	Wen Chin Lin, et al.
		Art Unit	2816
		Examiner Name	To Be Determined
SHEET 1	OF 1	Attorney Docket Number	24061.24

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(use as many sheets as necessary)

U. S. PATENT DOCUMENTS

Examiner's Initials	Cite No.	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
ah	AA	6,005,800	12-21-1999	Koch, et al.
ah	AB	6,335,890	01-01-2002	Reohr, et al.
ah	AC	6,490,217	12-03-2002	DeBrosse, et al.
ah	AD	6,509,621	01-21-2003	Nakao
ah	AE	6,522,579	02-18-2003	Hoenigschmid
ah	AF	6,567,299	05-20-2003	Kunikiyo, et al.
ah	AG	6,590,803	07-08-2003	Saito, et al.
ah	AH	6,594,191	07-15-2003	Lammers, et al.
ah	AI	6,621,731	09-16-2003	Bessho, et al.
ah	AJ	6,661,689	12-09-2003	Asao, et al.
ah	AK	6,693,822	02-17-2004	Ito
ah	AL	6,693,826	02-17-2004	Black, Jr., et al.

FOREIGN PATENT DOCUMENTS

Examiner's Initials	Cite No.	Foreign Patent Document (Country Code – Number – Kind)	Publication Date MM-DD-YYYY	Patentee or Applicant of Cited Document	Translation Y/N

OTHER PRIOR ART

Examiner's Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article, title of the item, date, page(s), volume-issue number(s), publisher, city/country where published

Examiner Signature		Date Considered	08/18/05

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include a copy of this form with next communication to applicant.

In place of PTO-1449 Form	U. S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	Complete if Known	
JAN 2 9 2004		Application Number	10/685,824
	INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Filing Date	October 13, 2003
	(use as many sheets as necessary)	Applicant(s)	Lin et al.
		Art Unit	Unknown
		Examiner Name	Unknown
SHEET	OF	Attorney Docket Number	24061.24

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OTHER PRIOR ART

Examiner's Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article, title of the item, date, page(s), volume-issue number(s), publisher, city/country where published.
AA	AA	F. MONTAIGNE, et al., "Enhanced Tunnel Magnetoresistance at High Bias Voltage in Double-Barrier Plannar Junctions", Volume 73, Number 19, November 9, 1998, American Institute of Physics
AB	AB	Y. SAITO, et al., "Correlation Between Barrier Width, Barrier Height, and DC Bias Voltage Dependences on the Magnetoresistance Ratio in IR-MN Exchanged Biased Single and Double Tunnel Junctions", Volume 39, pp. L1035 – L1038, Part 2 No. 10B, October 2000, The Japan Society of Applied Physics.

Examiner Signature		Date Considered	08/18/05